## Applicant(s)/Patent Under Application/Control No. Reexamination 10/518,153 NAKAHARA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1742 Sikyin Ip **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Е US-F US-G US-Н US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY 2000141078 05-2000 JΡ Ν 12-2001 JΡ 2001334384 O Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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